

# HYG110P04LQ1C2-VB Datasheet P-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)		
- 40	0.010 at V <sub>GS</sub> = - 10 V	- 40	42.6 nC		
- 40	0.012 at V <sub>GS</sub> =-4.5 V	- 35	42.0110		

**Bottom View** 

DFN5X6

**Top View** 

#### **FEATURES**

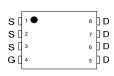
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET
- 100% R<sub>a</sub> and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

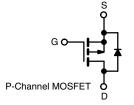


#### **APPLICATIONS**

- Load Switch
- Motor Drives







Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	- 40	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
	T <sub>C</sub> = 25 °C		- 40	
Continuous Drain Current (T 150 °C)	T <sub>C</sub> = 70 °C	1 , —	- 32	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 14.6 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		- 11.3 <sup>a, b</sup>	
Pulsed Drain Current (t = 300 μs)	I <sub>DM</sub>	- 70	A	
Continuous Course Brain Binds Courset	T <sub>C</sub> = 25 °C		- 35 <sup>d</sup>	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>S</sub>	- 4.3 <sup>a, b</sup>	
Avalanche Current	1 0.4 mal l	I <sub>AS</sub>	- 30	
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	45	mJ
	T <sub>C</sub> = 25 °C		39	
Manifestor Disease Disease at the	T <sub>C</sub> = 70 °C		25	147
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	5 <sup>a, b</sup>	W
	T <sub>A</sub> = 70 °C		3.2 <sup>a, b</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	00
Soldering Recommendations (Peak Temperature) <sup>e, f</sup>		Ů	260	°C

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>a, c</sup>	t ≤ 10 s	$R_{thJA}$	20	25	°C/W		
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	2.1	3.2	C/VV		

#### Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 54 °C/W.



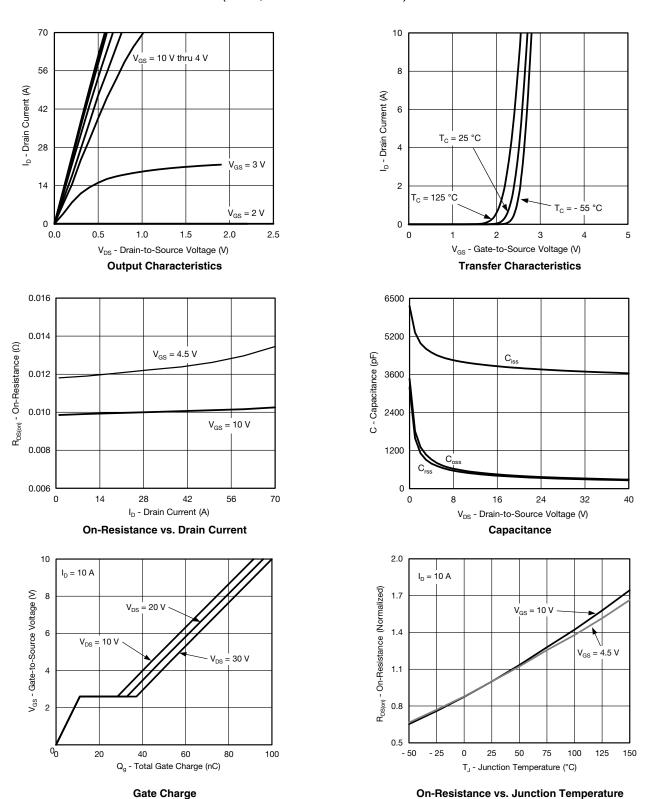
Parameter	Symbol Test Conditions		Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{DS}$ $V_{GS} = 0$ , $I_D = -250 \mu\text{A}$				V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	$I_D = -250 \mu\text{A}$		- 33		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			5		mv/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.2		- 2.3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
7 0 : 11 5 : 0 :	I <sub>DSS</sub>	V <sub>DS</sub> = - 40 V, V <sub>GS</sub> = 0 V			- 1	μΑ
Zero Gate Voltage Drain Current		V <sub>DS</sub> = - 40 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 5	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ - 10 V, V <sub>GS</sub> = - 10 V				Α
	D.	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 15 A		0.010		Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 10 A		0.012		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 15 A		40		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			3650		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		386		
Reverse Transfer Capacitance	C <sub>rss</sub>			350		
Total Cata Charge	Q <sub>g</sub>	$V_{DS} = -20 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -10 \text{ A}$		86	134	
Total Gate Charge				42.6	63	
Gate-Source Charge		$V_{DS} = -20 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A}$		10		nC
Gate-Drain Charge	Q <sub>gd</sub>			19.8		
Gate Resistance	$R_g$	f = 1 MHz	0.4	1.5	3.0	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			15	30	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 20 V, $R_L$ = 2 $\Omega$		14	28	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN} =$ - 10 V, $R_g = 1 \Omega$		56	110	]
Fall Time	t <sub>f</sub>			11	22	]
Turn-On Delay Time	t <sub>d(on)</sub>			60	110	ns
Rise Time	t <sub>r</sub>	$V_{DD} = -20 \text{ V}, R_{L} = 2 \Omega$		56	110	]
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -10 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		50	100	
Fall Time	t <sub>f</sub>			22	40	1
Drain-Source Body Diode Characterist	ics					
Continous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 50	Α
Pulse Diode Forward Current	I <sub>SM</sub>				- 70	^_
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 3 A, V <sub>GS</sub> = 0		- 0.74	- 1.1	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			29	55	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	L = 10 A dl/dt = 100 A/up T = 05 °C		25	46	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °\text{C}$		16		ns
Reverse Recovery Rise Time	t <sub>b</sub>	1		13		

#### Notes:

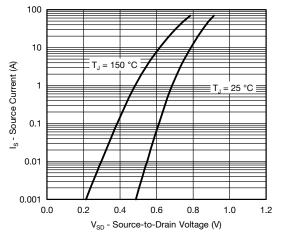
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

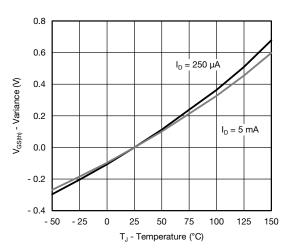




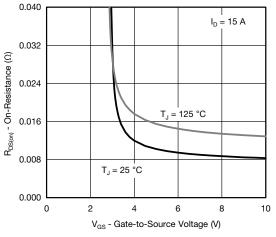




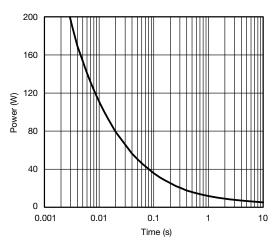
#### Source-Drain Diode Forward Voltage



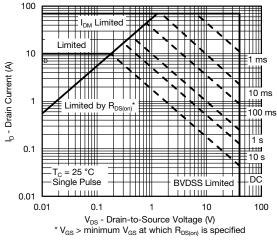
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage

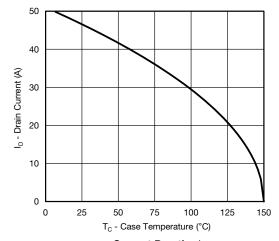


Single Pulse Power, Junction-to-Ambient

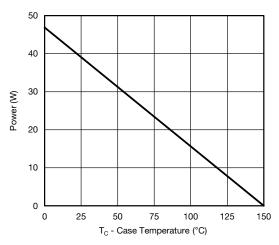


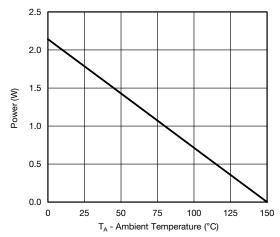
Safe Operating Area





#### **Current Derating\***





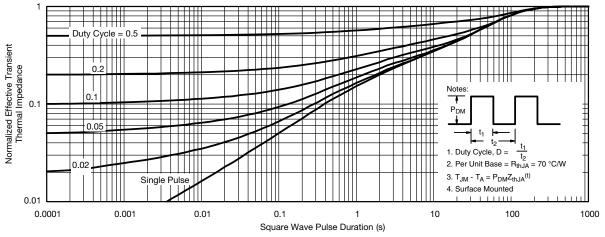
Power, Junction-to-Case

Power Derating, Junction-to-Ambient

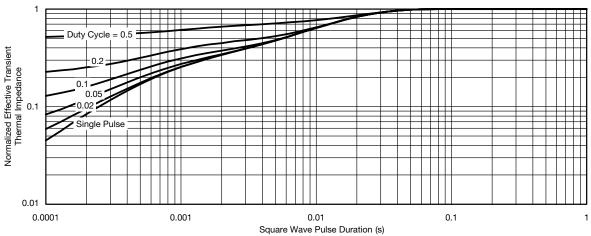
服务热线:400-655-8788 5

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





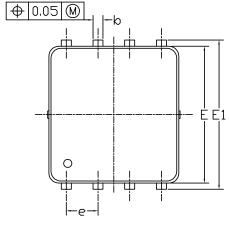
Normalized Thermal Transient Impedance, Junction-to-Ambient

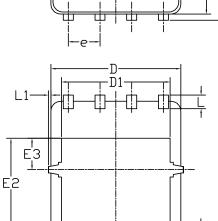


Normalized Thermal Transient Impedance, Junction-to-Case

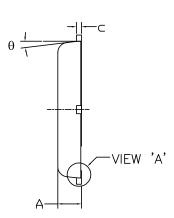


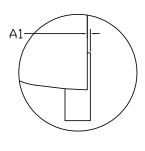
DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN





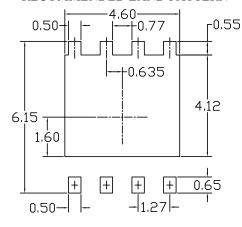
BOTTOM VIEW





<u>VIEW 'A'</u> (SCALE 5:1)

#### RECOMMENDED LAND PATTERN



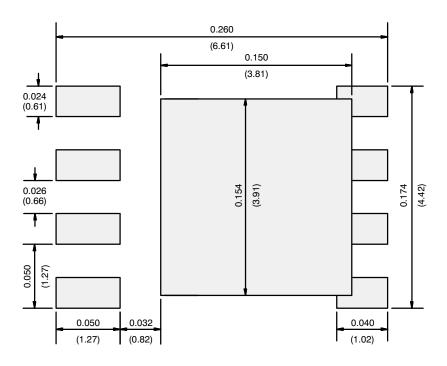
	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX
A	0.85	0. 95	1.00	0.033	0. 037	0. 039
A1	0.00		0.05	0.000		0.002
b	0.30	0.40	0.50	0.012	0.016	0.020
С	0.15	0.20	0. 25	0.006	0.008	0.010
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209
D1	4. 25	4. 35	4. 45	0. 167	0. 171	0. 175
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242
E2	3. 525	3. 625	3. 725	0.139	0. 143	0. 147
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054
e	1. 27 BSC			0.050 BSC		
L	0.45	0. 55	0.65	0.018	0.022	0.026
L1	0		0.15	0		0.006
L2	0.68 REF			0.027 REF		
θ	0°		10°	0°		10°

## NOTE

- UNIT: mm
- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



# RECOMMENDED MINIMUM PADS FOR PowerPAK® SO-8 Single



Recommended Minimum Pads Dimensions in Inches/(mm)



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